

AP3310GH-HF-VB Datasheet

P-Channel 30-V (D-S) MOSFET

PRODUCT SUMMARY

| V_{DS} (V) | $R_{DS(on)}$ (Ω) | I_D (A) ^d | Q_g (Typ.) |
|--------------|-----------------------------|------------------------|--------------|
| - 30 | 0.033 at $V_{GS} = - 10$ V | - 38 | 19 nC |
| | 0.046 at $V_{GS} = - 4.5$ V | - 25 | |

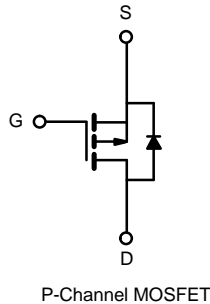
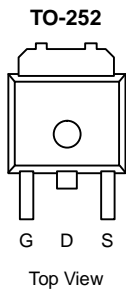
FEATURES

- Halogen-free
- TrenchFET[®] Power MOSFET
- 100 % R_g Tested
- 100 % UIS Tested


RoHS
 COMPLIANT

APPLICATIONS

- Load Switch
- Notebook Adaptor Switch



ABSOLUTE MAXIMUM RATINGS $T_A = 25$ °C, unless otherwise noted

| Parameter | Symbol | Limit | Unit |
|--|----------------|------------------------|------|
| Drain-Source Voltage | V_{DS} | - 30 | V |
| Gate-Source Voltage | V_{GS} | ± 20 | |
| Continuous Drain Current ($T_J = 150$ °C) | $T_C = 25$ °C | - 38 | A |
| | $T_C = 70$ °C | - 25 | |
| | $T_A = 25$ °C | - 14.9 ^{a, b} | |
| | $T_A = 70$ °C | - 13.6 ^{a, b} | |
| Pulsed Drain Current | I_{DM} | - 112 | |
| Continuous Source-Drain Diode Current | $T_C = 25$ °C | - 4.1 | |
| | $T_A = 25$ °C | - 2.2 ^{a, b} | |
| Avalanche Current | I_{AS} | - 20 | |
| Single-Pulse Avalanche Energy | E_{AS} | 20 | mJ |
| Maximum Power Dissipation | $T_C = 25$ °C | 25 | W |
| | $T_C = 70$ °C | 20 | |
| | $T_A = 25$ °C | 2.7 ^{a, b} | |
| | $T_A = 70$ °C | 1.7 ^{a, b} | |
| Operating Junction and Storage Temperature Range | T_J, T_{stg} | - 55 to 150 | °C |

THERMAL RESISTANCE RATINGS

| Parameter | Symbol | Typical | Maximum | Unit |
|---|------------|---------|---------|------|
| Maximum Junction-to-Ambient ^{a, c} | R_{thJA} | 38 | 46 | °C/W |
| Maximum Junction-to-Foot | R_{thJF} | 20 | 25 | |

Notes:

a. Surface mounted on 1" x 1" FR4 board.

 b. $t = 10$ s.

c. Maximum under Steady State conditions is 85 °C/W.

 d. Based on $T_C = 25$ °C.

| SPECIFICATIONS $T_J = 25\text{ }^{\circ}\text{C}$, unless otherwise noted | | | | | | | |
|--|-------------------------|---|-------|--------|-----------|---------------------------|--|
| Parameter | Symbol | Test Conditions | Min. | Typ. | Max. | Unit | |
| Static | | | | | | | |
| Drain-Source Breakdown Voltage | V_{DS} | $V_{GS} = 0\text{ V}$, $I_D = -250\text{ }\mu\text{A}$ | - 30 | | | V | |
| V_{DS} Temperature Coefficient | $\Delta V_{DS}/T_J$ | $I_D = -250\text{ }\mu\text{A}$ | | - 34 | | mV/ $^{\circ}\text{C}$ | |
| $V_{GS(th)}$ Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | | | 5.3 | | | |
| Gate-Source Threshold Voltage | $V_{GS(th)}$ | $V_{DS} = V_{GS}$, $I_D = -250\text{ }\mu\text{A}$ | - 1.0 | | - 2.5 | V | |
| Gate-Source Leakage | I_{GSS} | $V_{DS} = 0\text{ V}$, $V_{GS} = \pm 25\text{ V}$ | | | ± 100 | nA | |
| Zero Gate Voltage Drain Current | I_{DSS} | $V_{DS} = -30\text{ V}$, $V_{GS} = 0\text{ V}$ | | | - 1 | μA | |
| | | $V_{DS} = -30\text{ V}$, $V_{GS} = 0\text{ V}$, $T_J = 55\text{ }^{\circ}\text{C}$ | | | - 5 | | |
| On-State Drain Current ^a | $I_{D(on)}$ | $V_{DS} \geq -10\text{ V}$, $V_{GS} = -10\text{ V}$ | - 30 | | | A | |
| Drain-Source On-State Resistance ^a | $R_{DS(on)}$ | $V_{GS} = -10\text{ V}$, $I_D = -10\text{ A}$ | | 0.033 | | Ω | |
| | | $V_{GS} = -4.5\text{ V}$, $I_D = -8\text{ A}$ | | 0.046 | | | |
| Forward Transconductance ^a | g_{fs} | $V_{DS} = -10\text{ V}$, $I_D = -10\text{ A}$ | | 28 | | S | |
| Dynamic ^b | | | | | | | |
| Input Capacitance | C_{iss} | $V_{DS} = -15\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 1\text{ MHz}$ | | 1350 | | pF | |
| Output Capacitance | C_{oss} | | | 255 | | | |
| Reverse Transfer Capacitance | C_{rss} | | | 190 | | | |
| Total Gate Charge | Q_g | $V_{DS} = -15\text{ V}$, $V_{GS} = -10\text{ V}$, $I_D = -10\text{ A}$ | | 27 | 43 | nC | |
| | | $V_{DS} = -15\text{ V}$, $V_{GS} = -4.5\text{ V}$, $I_D = -10\text{ A}$ | | 19 | 25 | | |
| | | | | | 6 | | |
| | | | | | 12 | | |
| Gate-Source Charge | Q_{gs} | | | | | | |
| Gate-Drain Charge | Q_{gd} | | | | | | |
| Gate Resistance | R_g | $f = 1\text{ MHz}$ | 0.5 | 2.2 | 4.4 | Ω | |
| Turn-On Delay Time | $t_{d(on)}$ | $V_{DD} = -15\text{ V}$, $R_L = 1.5\text{ }\Omega$ $I_D \cong -10\text{ A}$, $V_{GEN} = -10\text{ V}$, $R_g = 1\text{ }\Omega$ | | 13 | 25 | ns | |
| Rise Time | t_r | | | 12 | 24 | | |
| Turn-Off DelayTime | $t_{d(off)}$ | | | 40 | 70 | | |
| Fall Time | t_f | | | 9 | 18 | | |
| Turn-On Delay Time | $t_{d(on)}$ | $V_{DD} = -15\text{ V}$, $R_L = 1.5\text{ }\Omega$ $I_D \cong -10\text{ A}$, $V_{GEN} = -4.5\text{ V}$, $R_g = 1\text{ }\Omega$ | | 48 | 80 | | |
| Rise Time | t_r | | | 92 | 160 | | |
| Turn-Off DelayTime | $t_{d(off)}$ | | | 34 | 60 | | |
| Fall Time | t_f | | | 19 | 35 | | |
| | | | | | | | |
| Drain-Source Body Diode Characteristics | | | | | | | |
| Continous Source-Drain Diode Current | I_S | $T_C = 25\text{ }^{\circ}\text{C}$ | | | - 4.1 | A | |
| Pulse Diode Forward Current | I_{SM} | | | | - 40 | | |
| Body Diode Voltage | V_{SD} | $I_S = -3\text{ A}$, $V_{GS} = 0\text{ V}$ | | - 0.75 | - 1.2 | V | |
| Body Diode Reverse Recovery Time | t_{rr} | $I_F = -10\text{ A}$, $di/dt = 100\text{ A}/\mu\text{s}$, $T_J = 25\text{ }^{\circ}\text{C}$ | | 27 | 45 | ns | |
| Body Diode Reverse Recovery Charge | Q_{rr} | | | 16 | 27 | nC | |
| Reverse Recovery Fall Time | t_a | | | 12 | | ns | |
| Reverse Recovery Rise Time | t_b | | | 15 | | | |

Notes:

a. Pulse test; pulse width $\leq 300\text{ }\mu\text{s}$, duty cycle $\leq 2\%$.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Output Characteristics



Transfer Characteristics



On-Resistance vs. Drain Current



Capacitance

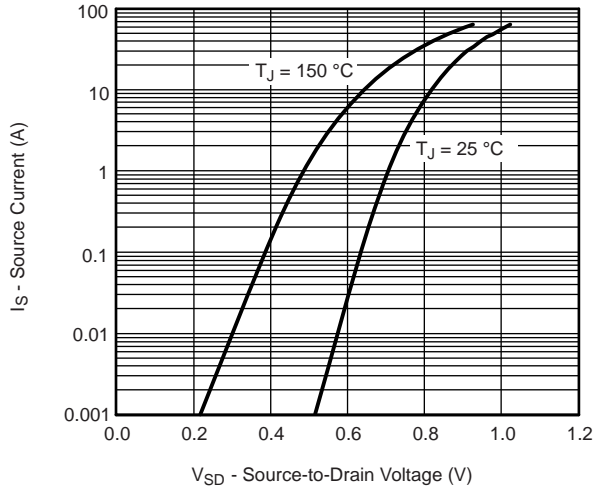


Gate Charge

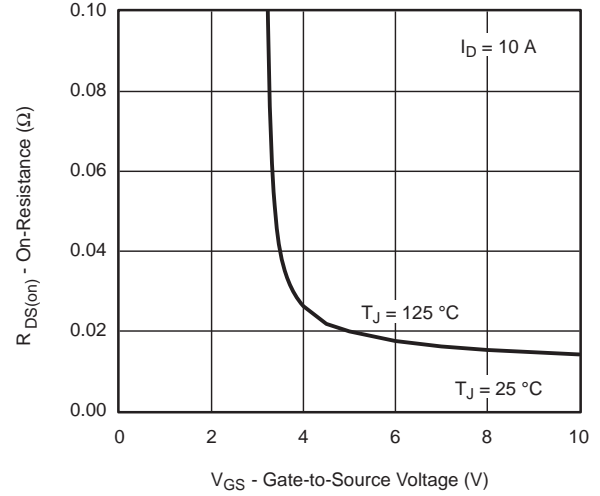


On-Resistance vs. Junction Temperature

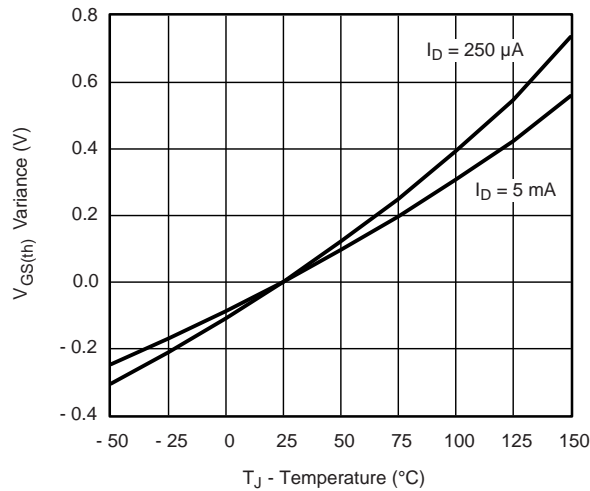
TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



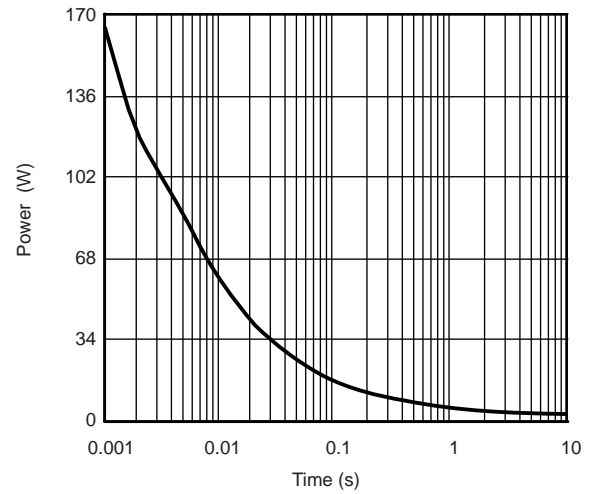
Source-Drain Diode Forward Voltage



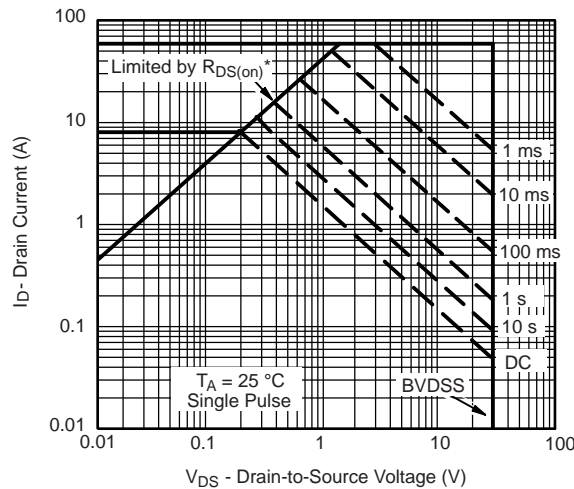
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



Single Pulse Power, Junction-to-Ambient



* $V_{GS} >$ minimum V_{GS} at which $R_{DS(on)}$ is specified

Safe Operating Area

MOSFET TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

Current Derating*

Power, Junction-to-Foot

Power Derating, Junction-to-Ambient

* The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

TO-252AA CASE OUTLINE

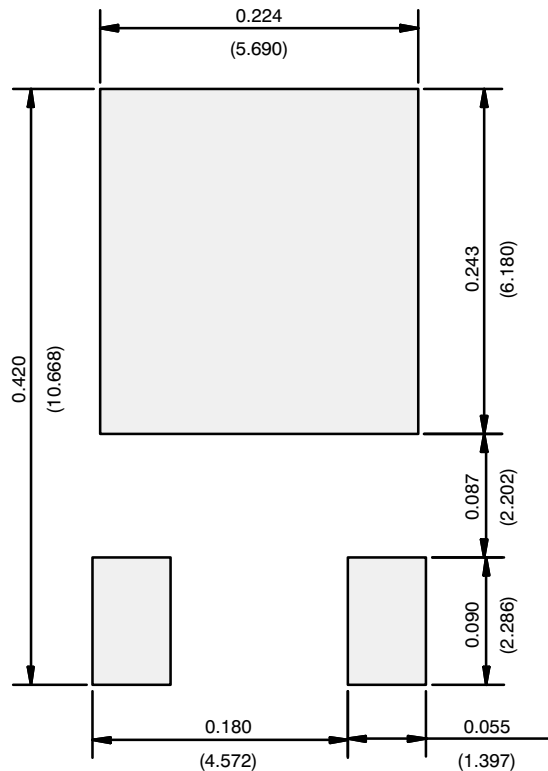


| DIM. | MILLIMETERS | | INCHES | |
|---------------------------------|-------------|-------|-----------|-------|
| | MIN. | MAX. | MIN. | MAX. |
| A | 2.18 | 2.38 | 0.086 | 0.094 |
| A1 | - | 0.127 | - | 0.005 |
| b | 0.64 | 0.88 | 0.025 | 0.035 |
| b2 | 0.76 | 1.14 | 0.030 | 0.045 |
| b3 | 4.95 | 5.46 | 0.195 | 0.215 |
| C | 0.46 | 0.61 | 0.018 | 0.024 |
| C2 | 0.46 | 0.89 | 0.018 | 0.035 |
| D | 5.97 | 6.22 | 0.235 | 0.245 |
| D1 | 5.21 | - | 0.205 | - |
| E | 6.35 | 6.73 | 0.250 | 0.265 |
| E1 | 4.32 | - | 0.170 | - |
| H | 9.40 | 10.41 | 0.370 | 0.410 |
| e | 2.28 BSC | | 0.090 BSC | |
| e1 | 4.56 BSC | | 0.180 BSC | |
| L | 1.40 | 1.78 | 0.055 | 0.070 |
| L3 | 0.89 | 1.27 | 0.035 | 0.050 |
| L4 | - | 1.02 | - | 0.040 |
| L5 | 1.14 | 1.52 | 0.045 | 0.060 |
| ECN: X12-0247-Rev. M, 24-Dec-12 | | | | |
| DWG: 5347 | | | | |

Note

- Dimension L3 is for reference only.

RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)



Recommended Minimum Pads
Dimensions in Inches/(mm)

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